

OT406 Four-quadrant triac, enhanced noise immunity Rev. 01 — 19 May 2008 P

Product data sheet

1. Product profile

1.1 General description

Passivated sensitive gate triac in a SOT223 surface-mountable plastic package

1.2 Features

Sensitive gate Gate triggering in four quadrants Direct interfacing to logic level ICs Direct interfacing to low power gate drive circuits Enhanced immunity to voltage Blocking voltage to 600 V transients and noise **1.3 Applications** Home appliances Low power motor control Low power loads in industrial process Low power AC fan speed controllers control 1.4 Quick reference data I_{GT} \leq 3 mA V_{DRM} ≤ 600 V I_{TSM} \leq 12.5 A (t = 20 ms) I_{GT} \leq 5 mA (T2–G+)

2. Pinning information

I $I_{T(RMS)} \le 1 \text{ A}$

Table 1.	Pinning		
Pin	Description	Simplified outline	Graphic symbol
1	main terminal 1 (T1)		N 1
2	main terminal 2 (T2)		T2-T1
3	gate (G)		Sym051
4	mounting base; main terminal 2 (T2)		
		SOT223	



3. Ordering information

Table 2. Ordering information						
Type number	Package					
	Name	Description	Version			
OT406	SC-73	plastic surface-mounted package with increased heatsink; 4 leads	SOT223			

4. Limiting values

Table 3. Limiting values

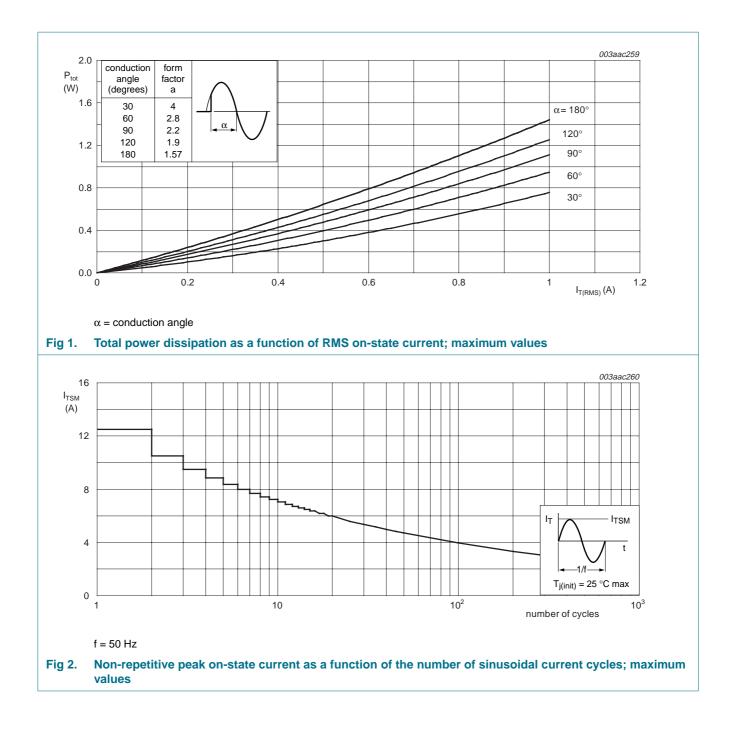
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DRM}	repetitive peak off-state voltage		-	600	V
V _{RRM}	repetitive peak reverse voltage		-	600	V
I _{T(RMS)}	RMS on-state current	full sine wave; $T_{sp} \le 103 \text{ °C}$; see Figure 4 and 5	-	1	А
ТЅМ	non-repetitive peak on-state current	full sine wave; $T_j = 25 \text{ °C}$ prior to surge; see Figure 2 and 3			
		t = 20 ms	-	12.5	А
		t = 16.7 ms	-	13.8	А
l ² t	I ² t for fusing	$t_p = 10 \text{ ms}$	-	1.28	A ² s
dl _T /dt	rate of rise of on-state current	$\begin{split} I_{TM} &= 1 \text{ A}; \text{ I}_{G} = 20 \text{ mA}; \\ dI_{G}/dt &= 0.2 \text{ A}/\mu\text{s} \end{split}$			
		T2+ G+	-	50	A/μs
		T2+ G–	-	50	A/μs
		T2– G–	-	50	A/μs
		T2– G+	-	10	A/μs
I _{GM}	peak gate current		-	1	А
P _{GM}	peak gate power		-	2	W
P _{G(AV)}	average gate power	over any 20 ms period	-	0.1	W
T _{stg}	storage temperature		-40	+150	°C
Tj	junction temperature		-	125	°C

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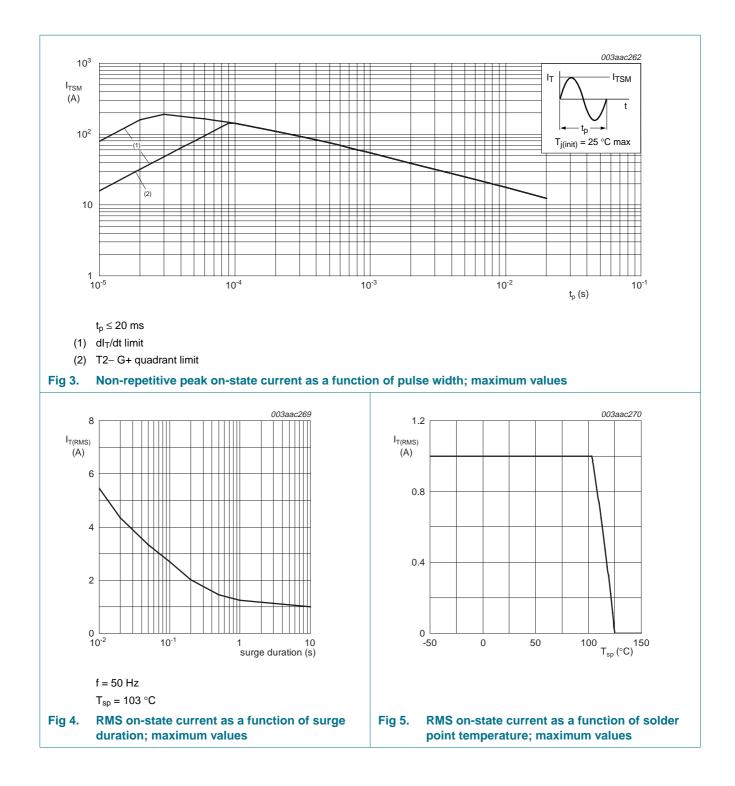
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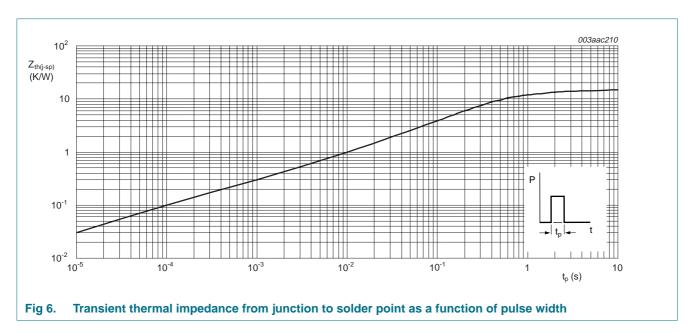
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5. Thermal characteristics

Thermal characteristics					
Parameter	Conditions	Min	Тур	Max	Unit
thermal resistance from junction to solder point	full cycle; see Figure 6	-	-	15	K/W
thermal resistance from junction to ambient	full cycle				
	for minimum footprint see <u>Figure 13</u>	-	156	-	K/W
	for pad area see <u>Figure 14</u>	-	70	-	K/W
	Parameterthermal resistance from junction to solder pointthermal resistance from junction to	Parameter Conditions thermal resistance from junction to solder point full cycle; see Figure 6 thermal resistance from junction to ambient full cycle for minimum footprint see Figure 13 for pad area	ParameterConditionsMinthermal resistance from junction to solder pointfull cycle; see Figure 6 full cycle; see Figure 6-thermal resistance from junction to ambientfull cycle for minimum footprint see Figure 13 for pad area-	ParameterConditionsMinTypthermal resistance from junction to solder pointfull cycle; see Figure 6 full cycle; see Figure 6thermal resistance from junction to ambientfull cycle for minimum footprint see Figure 13 for pad area-156	ParameterConditionsMinTypMaxthermal resistance from junction to solder pointfull cycle; see Figure 6 full cycle; see Figure 615thermal resistance from junction to ambientfull cycle for minimum footprint see Figure 13 for pad area-156-



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6. Static characteristics

Table 5.Static characteristics

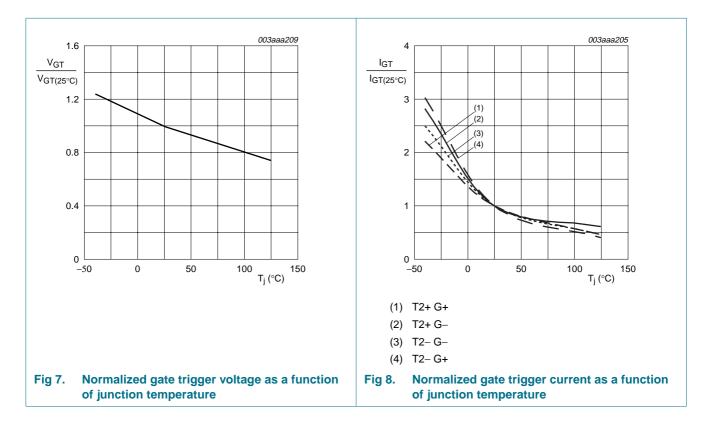
 $T_j = 25 \circ C$ unless otherwise specified.

,	1					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{GT}	gate trigger current	$V_D = 12 \text{ V}; \text{ I}_T = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 8}}{100000000000000000000000000000000000$				
		T2+ G+	-	-	3	mA
		T2+ G-	-	-	3	mA
		T2- G-	-	-	3	mA
		T2– G+	-	-	5	mA
IL	latching current	$V_D = 12 \text{ V}; \text{ I}_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure } 10}{100000000000000000000000000000000$				
		T2+ G+	-	-	7	mA
		T2+ G-	-	-	20	mA
		T2- G-	-	-	7	mA
		T2- G+	-	-	7	mA
I _H	holding current	$V_D = 12 \text{ V}; \text{ I}_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure } 11}{100000000000000000000000000000000$	-	-	7	mA
V _T	on-state voltage	I _T = 1 A; see <u>Figure 9</u>	-	1.3	1.6	V
V _{GT}	gate trigger voltage	$V_D = 12 \text{ V}; \text{ I}_T = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 7}}{100000000000000000000000000000000000$	-	-	1.3	V
		$V_D = V_{DRM}; I_T = 0.1 \text{ A}; T_j = 125 ^{\circ}\text{C}$	0.2	-	-	V
I _D	off-state current	$V_D = V_{DRM(max)}; T_j = 125 \ ^{\circ}C$	-	-	0.5	mA

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7. Dynamic characteristics

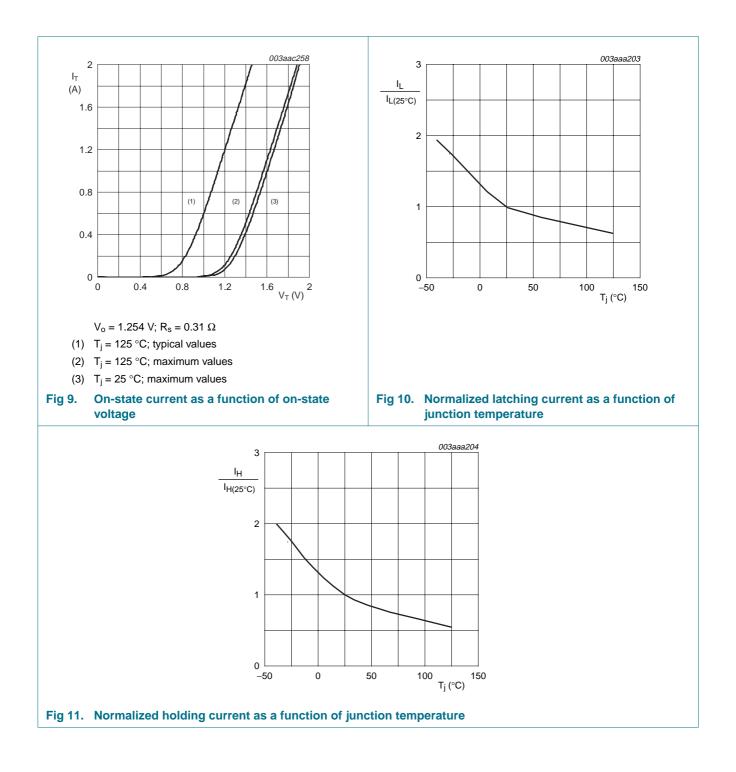
Table 6.	Dynamic characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 0.67 $V_{DRM(max)}$; T_j = 110 °C; exponential waveform; gate open circuit	10	-	-	V/µs
dV _{com} /dt	rate of change of commutating voltage	V_{DM} = 400 V; T _j = 110 °C; I _{TM} = 1 A; dI _{com} /dt = 0.44 A/ms	0.5	-	-	V/µs



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8. Package outline

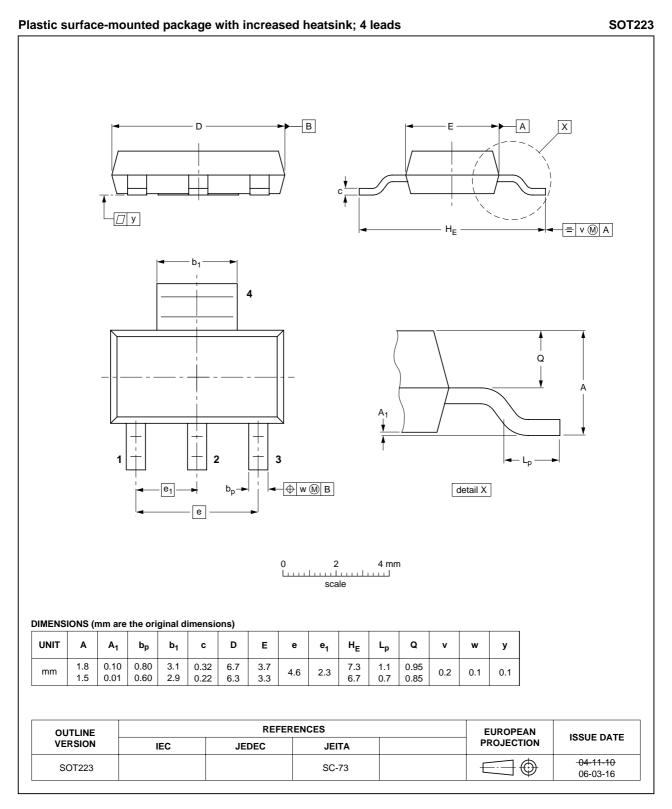
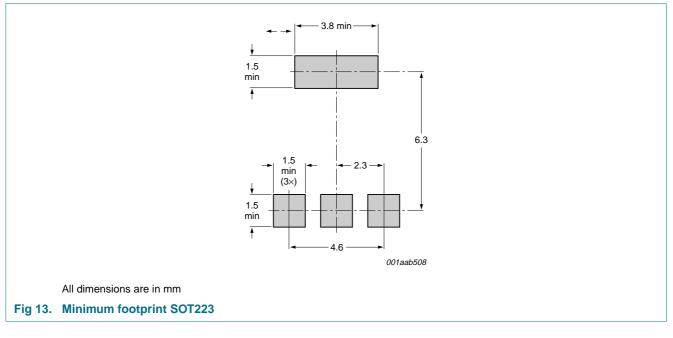


Fig 12. Package outline SOT223 (SC-73)

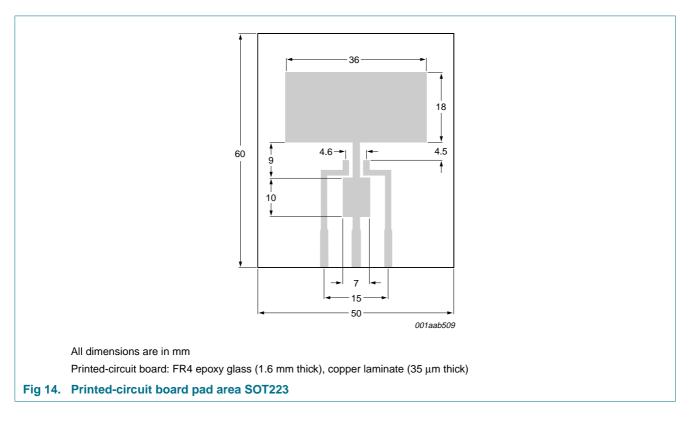
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9. Mounting

9.1 Mounting instructions



9.2 Printed-circuit board



10. Revision history

Table 7. Revision hist	Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes	
OT406_1	20080519	Product data sheet	-	-	

11. Legal information

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Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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